

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 107439-00089	SERIAL NO. 10/633,569
LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>		APPLICANT HANADA, et al.		
		FILING DATE August 5, 2003	GROUP 2837	

JUN 09 2004

U.S. PATENT DOCUMENTS						
EXAMINER INITIALS	DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
HA	AA 6,116,363	September 12, 2000	Andrew A. FRANK			April 21, 1998
	AB					
	AC					
	AD					
	AE					
	AF					

FOREIGN PATENT DOCUMENTS

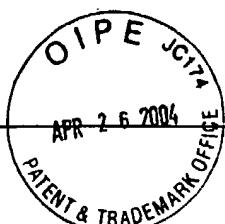
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO PART.
HA	AG	EP 1 128 044 A2	August 29, 2001	Europe			X
HA	AH	EP 0 755 816 A2	January 298, 1997	Europe			X
	AI						
	AJ						
	AK						
	AL						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

AM	
AN	
AO	

EXAMINER HA	DATE CONSIDERED 10/4/04
----------------	----------------------------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Sheet 1 of 1

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 107439-00089	SERIAL NO. 10/633,569
LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>		APPLICANT HANADA, et al.		
		FILING DATE August 5, 2003	GROUP 2837	

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES NO PART.
HA	AG	2002-054474	February 20, 2002	Japan			X
HA	AH	2002-070599	March 8, 2002	Japan*			
HA	AI	11-182275	July 6, 1999	Japan			X
HA	AJ	2000-027670	January 25, 2000	Japan			X
HA	AK	2002-013423	January 18, 2002	Japan			X
HA	AL	2001-207886	August 3, 2001	Japan			X

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AM	
	AN	
	AO	

EXAMINER	HA	DATE CONSIDERED	10/4/04
----------	----	-----------------	---------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

* Previously submitted on August 5, 2003.

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 107439-00089	SERIAL NO. Unknown
LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>		APPLICANT HANADA, et al.	
		FILING DATE August 5, 2003	GROUP Unknown

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
HA	AA	5,789,881	August 4, 1998	EGAMI, et al.			Dec. 27, 1996
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES NO PART.
	AG	2002-070599	March 8, 2002	Japan			X
	HA	11-350995	Dec. 21, 1999	Japan			X
	AI						
	AJ						
	AK						
	AL						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AM	
	AN	
	AO	

EXAMINER	DATE CONSIDERED
HA	10/4/04

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.